

<b>Notice of References Cited</b>	Application/Control No. 10/827,072		Applicant(s)/Patent Under Reexamination KUMAR ET AL.	
	Examiner Dah-Wei D. Yuan		Art Unit 1745	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,534,216	03-2003	Narukawa et al.	429/224
*	B	US-6,638,662	10-2003	Kaneda et al.	429/231.8
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

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